Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/750,275	LUCIANO ET AL.	
Examiner	Art Unit	
Pyan Heij	3714	

SEARCHED			
Class	Subclass	Date	Examiner
463	16-20, 25- 29, 40-42	2/22/2007	RH
273	138.1-2	2/22/2007	RH
<u>. </u>			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
see updated EAST search notes	2/22/2007	RH
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